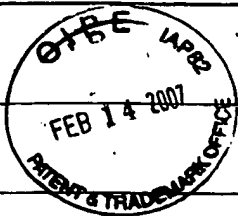


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>275876US6PCT</b>		SERIAL NO. <b>10/524,521</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Mitsutoshi TERADA, et al.</b>			
				FILING DATE <b>April 24, 2006</b>		GROUP <b>2627</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/ME/	AA	2002/0021635 A1	2/21/2002	Sang On PARK, et al.			
	AB						
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	AH						
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	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES                      NO		
/ME/	AO	EP 1 139 345 A2	10/4/2001	Europe			
/ME/	AP	EP 0 933 761 A2	8/4/1999	Europe			
/ME/	AQ	JP 2002-245752	8/30/2002	Japan (submitting English Abstract only, reference filed 2/11/2005)			
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner     /Muhammad Edun/ (03/02/2008)					Date Considered     03/02/2008		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							



Docket No.: 275876US6PCT

Serial No.: 10/524,521

Inventor: Mitsutoshi TERADA, et al.

LIST OF RELATED CASES CITED BY  
APPLICANT UNDER 37 CFR 1.56

Filing Date: April 24, 2006

Group: 2626

**LIST OF RELATED CASES**

<u>Examiner Initial</u>	<u>Docket No.</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent App. Publication No.</u>	<u>Inventor or Applicant</u>
/ME/	275876US6PCT*	10/524,521	04/24/06	2006-0233078	TERADA et al.
/ME/	298545US8CONT	11/560,249	11/15/06		TERADA et al.

Examiner /Muhammad Edun/ (03/02/2008) Date Considered 03/02/2008

\*Present Application; listed for information

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Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05120	SERIAL NO. 10/524521 Filed Concurrently Herewith
	APPLICANT Mitsutoshi TERADA et al.	
	FILING DATE Filed Concurrently Herewith	GROUP

LIST OF REFERENCES CITED BY APPLICANT  
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ		
	AR		
	AS		

EXAMINER /Muhammad Edun/ (03/02/2008)	DATE CONSIDERED 03/02/2008
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